

Shenzhen Zhongjian Nanfang Testing Co., Ltd.

Report No: CCIS14120103501

FCC REPORT

Applicant: Shenzhen Wearable Technology Co., Ltd

Address of Applicant:

Room 319,320, Baiwangxin technology building, No. 1002,

Songbai road, Nanshan district, Shenzhen China

Equipment Under Test (EUT)

Product Name: Little ding tong smart watches

Model No.: C001, C002, C003

FCC ID: 2ADUA-C001

FCC CFR Title 47 Part 2

Applicable standards: FCC CFR Title 47 Part 22 Subpart H

FCC CFR Title 47 Part 24 Subpart E

Date of sample receipt: 15 Dec., 2014

Date of Test: 15 Dec., 2014 to 01 Jun, 2015

Date of report issued: 02 Jun., 2015

Test Result: PASS *

* In the configuration tested, the EUT complied with the standards specified above.

Authorized Signature:



Bruce Zhang Laboratory Manager

This report details the results of the testing carried out on one sample. The results contained in this test report do not relate to other samples of the same product and does not permit the use of the CCIS product certification mark. The manufacturer should ensure that all products in series production are in conformity with the product sample detailed in this report.

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2. Version

Version No.	Date	Description
00	02 Jun., 2015	Original

Luna Gas
Report Clerk Prepared by: Date: 02 Jun., 2015

Reviewed by: Date: 02 Jun., 2015

Project Engineer



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4. Test Summary

Test Item	Section in CFR 47	Result
RF Exposure (SAR)	Part 1.1307 Part 2.1093	Passed* (Please refer to SAR Report)
RF Output Power	Part 2.1046 Part 22.913 (a)(2) Part 24.232 (c)	Pass
Modulation Characteristics	Part 2.1047	Pass
99% & -26 dB Occupied Bandwidth	Part 2.1049 Part 22.917 Part 24.238	Pass
Spurious Emissions at Antenna Terminal	Part 2.1051 Part 22.917 (a) Part 24.238 (a)	Pass
Field Strength of Spurious Radiation	Part 2.1053 Part 22.917 (a) Part 24.238 (a)	Pass
Out of band emission, Band Edge	Part 22.917 (a) Part 24.238 (a)	Pass
Frequency stability vs. temperature	Part 2.1055(a)(1)(b)	Pass
Frequency stability vs. voltage	Part 2.1055(d)(1)(2)	Pass

Pass: The EUT complies with the essential requirements in the standard.



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5. General Information

5.1 Client Information

Applicant:	Shenzhen Wearable Technology Co. , Ltd
Address of Applicant:	Room 319, 320, Baiwangxin technology building, No. 1002, Songbai road, Nanshan district, Shenzhen China
Manufacturer:	Shenzhen Wearable Technology Co. , Ltd
Address of Manufacturer:	Room 319, 320, Baiwangxin technology building, No. 1002, Songbai road, Nanshan district, Shenzhen, China
Factory:	Huizhou Algentra Electronics Co.,Ltd
Address of Factory:	4 th FL, NO.1 of Huifeng East 1'st Road, HuiTai Industriall area, Huizhou, Guangdong, China

5.2 General Description of E.U.T.

Product Name:	Little ding tong smart watches
Model No.:	C001, C002, C003
Operation Frequency range:	GSM 850: 824.20MHz-848.80MHz PCS1900: 1850.20MHz-1909.80MHz
Modulation type:	GSM/GPRS:GMSK
Antenna type:	Internal Antenna
Antenna gain:	GSM 850: -0.7 dBi PCS 1900: 0 dBi GPS: 1.8dBi
Power supply:	Rechargeable Li-ion Battery DC3.7V-330mAh
Remark:	Model No.: C001, C002, C003 were identical inside, the electrical circuit design, layout, components used and internal wiring, with only difference being only the model name, appearance and color.





Operation Frequency List:

GSN	<i>l</i> 850	PCS1900		
Channel:	Frequency (MHz)	Channel:	Frequency (MHz)	
128	824.20	512	1850.20	
129	824.40	513	1850.40	
189	836.40	660	1879.80	
190	836.60	661	1880.00	
191	836.80	662	1880.20	
250	848.60	809	1909.60	
251	848.80	810	1909.80	

Regards to the operating frequency range over 10 MHz, the Lowest frequency, the middle frequency, and the highest frequency of channel were selected to perform the test, and the selected channel see below:

GSM850			PCS1900		
Channe	el	Frequency(MHz)	Channel		Frequency(MHz)
Lowest channel	128	824.20	Lowest channel 512		1850.20
Middle channel	190	836.60	Middle channel	661	1880.00
Highest channel	251	848.80	Highest channel	810	1909.80



5.3 Test modes

Communicate mode (GSM850)	Keep the EUT in communicating mode on GSM 850 band.
Data mode (GPRS850)	Keep the EUT in data communicating mode on GPRS 850 band.
Communicate mode (PCS1900)	Keep the EUT in communicating mode on PCS1900 band.
Data mode (GPRS1900)	Keep the EUT in data communicating mode on GPRS1900 band.
Domork	Pre-test output power of all modes, and found GSM 850, PCS
Remark :	1900 were the worst case. The details please refer to section 6.5.

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5.4 Related Submittal(s) / Grant (s)

This submittal(s) (test report) is filing to comply with Section Part 22 subpart H and Part 24 subpart E of the FCC CFR 47 Rules.

5.5 Test Methodology

Both conducted and radiated testing were performed according to the procedures document on TIA/EIA 603 and FCC CFR 47.1046, 2.1047, 2.1049, 2.1051, 2.1053, 2.1055 and 2.1057

5.6 Laboratory Facility

The test facility is recognized, certified, or accredited by the following organizations:

• FCC - Registration No.: 817957

Shenzhen Zhongjian Nanfang Testing Co., Ltd. EMC Laboratory has been registered and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in out files. Registration 817957, February 27, 2012.

• IC - Registration No.: 10106A-1

The 3m Semi-anechoic chamber of Shenzhen Zhongjian Nanfang Testing Co., Ltd. has been Registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing with Registration No.: 10106A-1.

• CNAS - Registration No.: CNAS L6048

Shenzhen Zhongjian Nanfang Testing Co., Ltd. is accredited to ISO/IEC 17025:2005 General Requirements for the Competence of Testing and Calibration laboratories for the competence of testing. The Registration No. is CNAS L6048.

5.7 Laboratory Location

Shenzhen Zhongjian Nanfang Testing Co., Ltd.

Address: No. B-C, 1/F., Building 2, Laodong No.2 Industrial Park, Xixiang Road,

Bao'an District, Shenzhen, Guangdong, China

Tel: +86-755-23118282 Fax: +86-755-23116366





5.8 Test Instruments list

Radiated Emission:						
Item	Test Equipment	Manufacturer	Model No.	Inventory No.	Cal. Date (mm-dd-yy)	Cal. Due date (mm-dd-yy)
1	3m Semi- Anechoic Chamber	SAEMC	9(L)*6(W)* 6(H)	CCIS0001	08-23-2014	08-22-2017
2	BiConiLog Antenna	SCHWARZBECK MESS-ELEKTRONIK	VULB9163	CCIS0005	03-28-2015	03-28-2016
3	Double -ridged waveguide horn	SCHWARZBECK MESS-ELEKTRONIK	BBHA9120D	CCIS0006	03-28-2015	03-28-2016
4	EMI Test Software	AUDIX	E3	N/A	N/A	N/A
5	Amplifier (10kHz-1.3GHz)	HP	8447D	CCIS0003	04-01-2015	03-31-2016
6	Amplifier (1GHz-18GHz)	Compliance Direction Systems Inc.	PAP-1G18	CCIS0011	04-01-2015	03-31-2016
7	Pre-amplifier (18-26GHz)	Rohde & Schwarz	AFS33-18002 650-30-8P-44	GTS218	04-01-2015	03-31-2016
8	Horn Antenna	ETS-LINDGREN	3160	GTS217	04-01-2015	03-31-2016
9	Printer	HP	HP LaserJet P1007	N/A	N/A	N/A
10	Positioning Controller	UC	UC3000	CCIS0015	N/A	N/A
11	Spectrum analyzer 9k-30GHz	Rohde & Schwarz	FSP 30	CCIS0023	03-28-2015	03-28-2016
12	EMI Test Receiver	Rohde & Schwarz	ESPI	CCIS0022	03-28-2015	03-28-2016
13	Loop antenna	Laplace instrument	RF300	EMC0701	04-01-2015	03-31-2016
14	Universal radio communication tester	Rhode & Schwarz	CMU200	CCIS0069	03-28-2015	03-28-2016
15	Signal Analyzer	Rohde & Schwarz	FSIQ3	CCIS0088	04-08-2015	04-08-2016



6. System test configuration

6.1 EUT Configuration

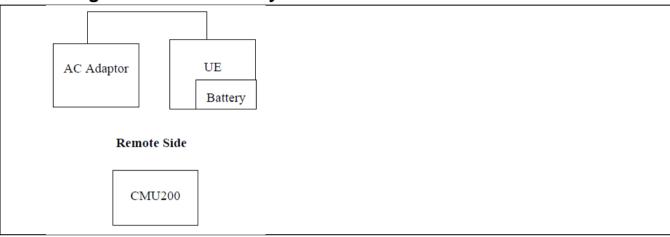
The EUT configuration for testing is installed on RF field strength measurement to meet the commission's requirement and operating in a manner which intends to maximize its emission characteristics in a continuous normal application.

6.2 EUT Exercise

The EUT (Transmitter) was operated in the engineering mode to fix the Tx frequency which was for the purpose of the measurements.

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6.3 Configuration of Tested System



6.4 Description of Test Modes

The EUT has been tested under operating condition.

EUT staying in continuous transmitting mode. Channel Low, Mid and High for each type band with rated data rate were chosen for full testing.

The field strength of spurious radiation emission was measured as EUT stand-up position (H mode) and lie down position (E1, E2 mode) for three modes (GSM850, PCS1900) with power adaptor, earphone and Data cable. The worst-case H mode for GSM850, PCS1900.





6.5 Conducted Output Power

Test Requirement:	FCC part 22.913(a) and FCC part 24.232(b)			
Test Method:	FCC part 2.1046			
Limit:	GSM 850 7W PCS 1900 2W			
Test setup:	EUT ATT Communication Tester Note: Measurement setup for testing on Antenna connector			
Test Procedure:	The transmitter output was connected to a calibrated attenuator, the other end of which was connected to the CMU200. Transmitter output power was read off in dBm.			
Test Instruments:	Refer to section 5.8 for details			
Test mode:	Refer to section 5.3 for details			
Test results:	Passed			

Measurement Data

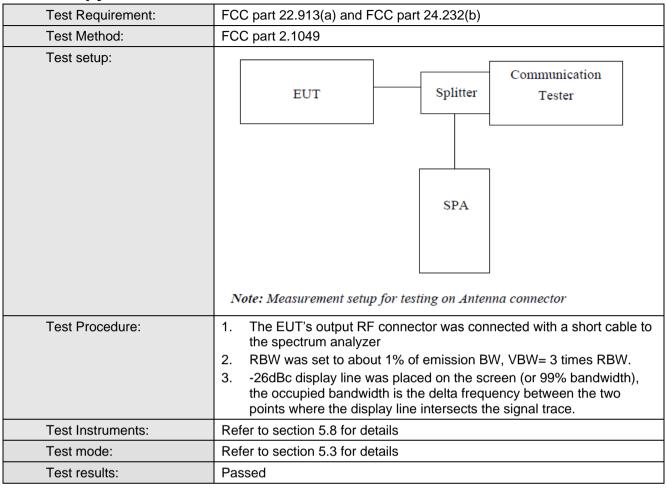




EUT Mode	Channel	Frequency (MHz)	Burst Average power (dBm)	Limit(dBm)	Result
	128	824.20	32.73		
GSM 850	190	836.60	32.73		
	251	848.80	32.75		
GPRS 850	128	824.20	32.67		
(1 Uplink slot)	190	836.60	32.68		
(1 Opinik slot)	251	848.80	32.68		
GPRS 850	128	824.20	32.17		
(2 Uplink slots)	190	836.60	32.12	38.45	Pass
(2 opinik didio)	251	848.80	32.04		
GPRS 850	128	824.20	31.26		
(3 Uplink slots)	190	836.60	31.37		
(6.616)	251	848.80	31.50		
GPRS 850	128	824.20	30.73		
(4 Uplink slots)	190	836.60	30.58		
, ,	251	848.80	30.50		
	512	1850.20	25.31		
PCS 1900	661	1880.00	25.38		
	810	1909.80	25.52		
0000 4000	512	1850.20	25.30		
GPRS 1900 (1 Uplink slot)	661	1880.00	25.36		
(1 Oplitik Siot)	810	1909.80	25.53		
0000 4000	512	1850.20	25.12		
GPRS 1900 (2 Uplink slots)	661	1880.00	25.16	33.00	Pass
(2 Oplitik Siots)	810	1909.80	25.49		
0000 4000	512	1850.20	24.79		
GPRS 1900 (3 Uplink slots)	661	1880.00	24.83		
	810	1909.80	24.91		
0000 4000	512	1850.20	21.36		
GPRS 1900 (4 Uplink slots)	661	1880.00	24.50		
(4 Oplink Siots)	810	1909.80	24.66		



6.6 Occupy Bandwidth



Measurement Data

EUT Mode	Channel	Frequency (MHz)	99% Occupy bandwidth (kHz)	-26dB bandwidth (kHz)
	128	824.2	244	316
GSM 850	190	836.6	244	316
	251	848.8	244	316
	512	1850.2	242	322
PCS 1900	661	1880.0	242	312
	810	1909.8	240	318

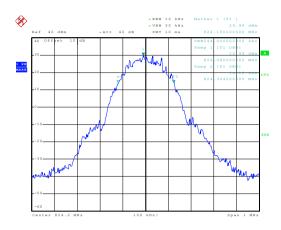
Note: GSM & GPRS use the same modulation technical (GMSK), and with the same channels, so the 99% OBW and the -26dB of GPRS not performed.

Test plot as follows:



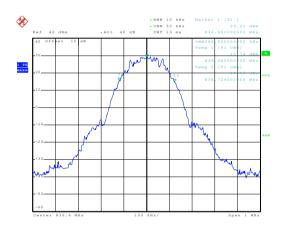
99% Occupy bandwidth

GSM850



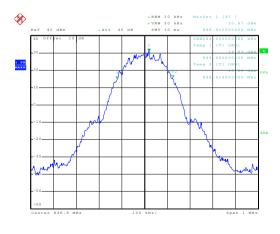
Date: 15.JAN.2015 15:37:45

Lowest channel



Date: 15.JAN.2015 15:38:51

Middle channel



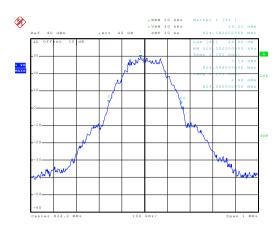
Date: 15..TAN.2015 15:39:19

Highest channel



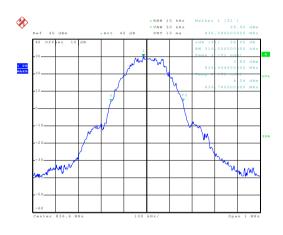
26dB Emission Bandwidth

GSM850



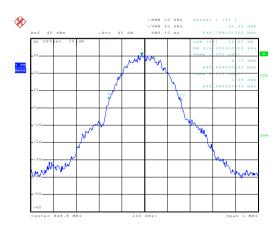
Date: 15.JAN.2015 15:38:02

Lowest channel



Date: 15.JAN.2015 15:38:30

Middle channel



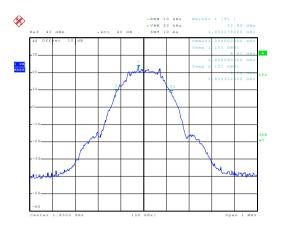
Date: 15.JAN.2015 15:39:35

Highest channel



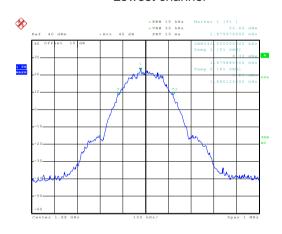
99% Occupy bandwidth

PCS 1900



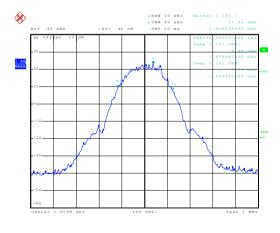
Date: 30.MAR.2015 20:37:56

Lowest channel



Date: 30.MAR.2015 20:40:16

Middle channel



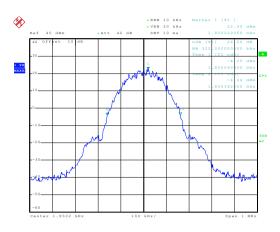
Date: 30.MAR.2015 20:41:05

Highest channel



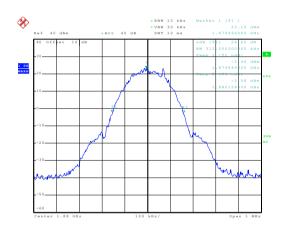
26dB Emission Bandwidth

PCS 1900



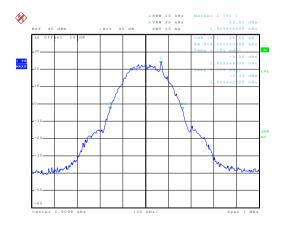
Date: 30.MAR.2015 20:38:12

Lowest channel



Date: 30.MAR.2015 20:39:44

Middle channel



Date: 30.MAR.2015 20:42:12

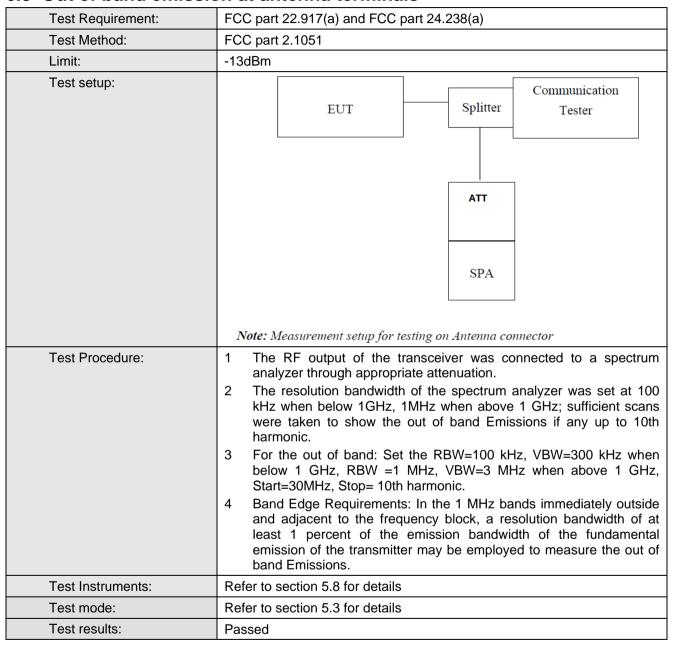
Highest channel



6.7 Modulation Characteristic

According to FCC § 2.1047(d), Part 22H & 24E there is no specific requirement for digital modulation, therefore modulation characteristic is not presented.

6.8 Out of band emission at antenna terminals



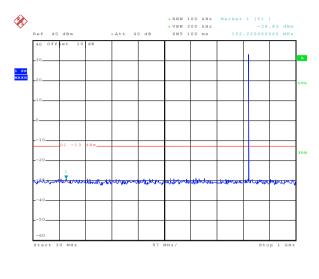
Test plots as follows:

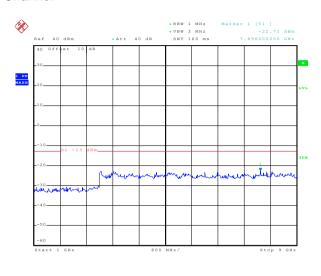


Spurious emission

GSM 850

Lowest Channel



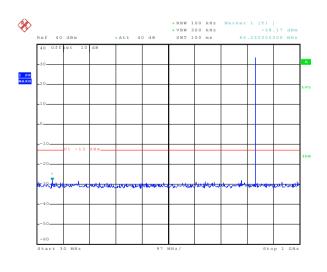


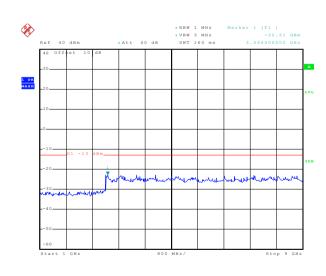
Date: 15.JAN.2015 15:35:04

30MHz~1GHz

Date: 15.JAN.2015 15:35:22 1GHz~9GHz

Middle channel





Date: 15.JAN.2015 15:34:47

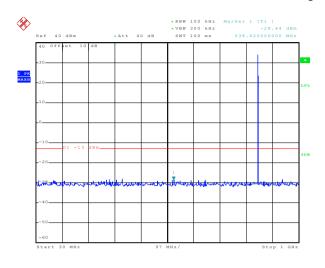
30MHz~1GHz

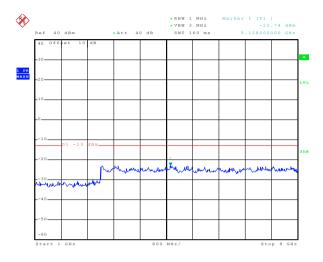
1GHz~9GHz

Date: 15.JAN.2015 15:35:36



Highest Channel





Date: 15.JAN.2015 15:34:25

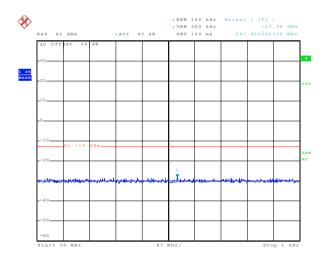
30MHz~1GHz

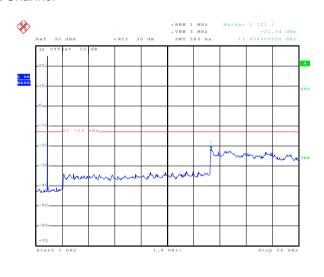
1GHz~9GHz

Date: 15.JAN.2015 15:37:17

PCS 1900

Lowest Channel





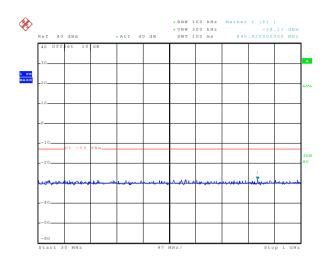
Date: 30.MAR.2015 20:36:50

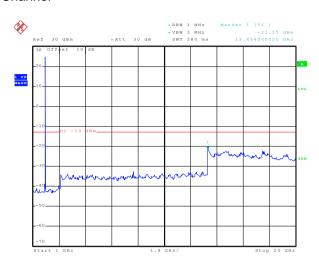
30MHz~1GHz

Date: 30.MAR.2015 21:40:35 1GHz~20GHz



Middle Channel

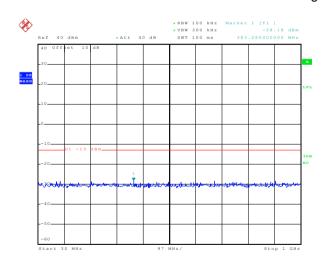


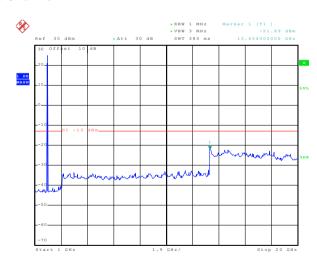


Date: 30.MAR.2015 20:35:59

30MHz~1GHz

Highest Channel





Date: 30.MAR.2015 20:34:38

30MHz~1GHz

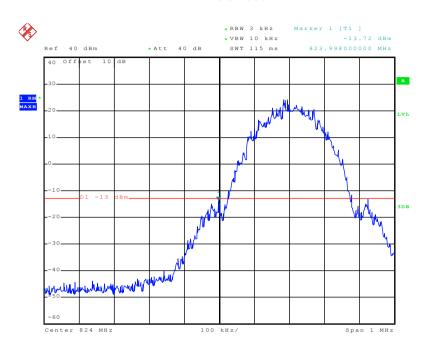
Date: 30.MAR.2015 21:42:10

1GHz~20GHz



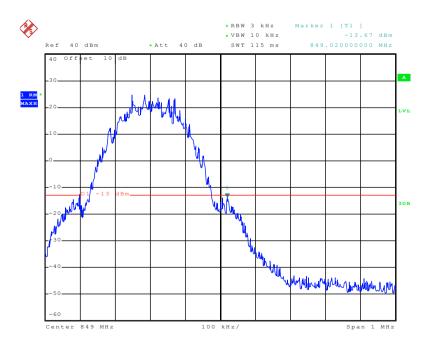
Band edge emission

GSM850



Date: 15.JAN.2015 15:31:45

Lowest channel

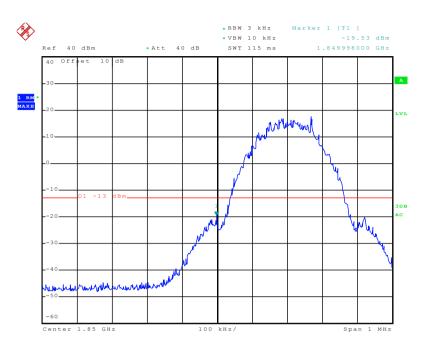


Date: 15.JAN.2015 15:33:49

Highest channel

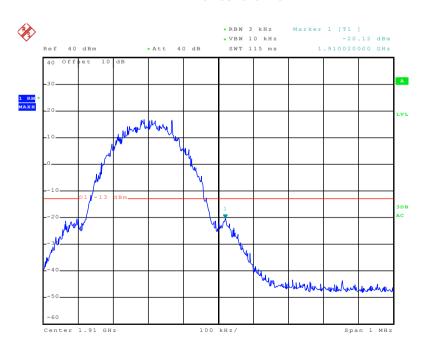






Date: 30.MAR.2015 20:32:17

Lowest channel



Date: 30.MAR.2015 20:34:06

Highest channel





6.9 ERP, EIRP Measurement

Test Requirement:	FCC part 22.913(a) and FCC part 24.232(b)
Test Method:	FCC part 2.1046
Limit:	GSM850 7W ERP PCS1900 2W EIRP
Test setup:	Below 1GHz Antenna Tower Search Antenna RF Test Receiver Ground Plane Above 1GHz
	Antenna Tower Horn Antenna Spectrum Analyzer Turn Table Amplifier
	Substituted method:
	Ground plane d: distance in meters d:3 meter 1-4 meter Substituted Dipole or Horn Antenna Bi-Log Antenna or Horn Antenna





Test Procedure:	 The EUT was placed on an non-conductive turntable using a non- conductive support. The radiated emission at the fundamental frequency was measured at 3 m with a test antenna and EMI spectrum analyzer. 		
	2. During the measurement, the EUT was communication with the station. The highest emission was recorded with the rotation of the turntable and the lowering of the test antenna from 4m to 1m. The reading was recorded and the field strength (E in dBuV/m) was calculated.		
	3. ERP in frequency band 824.2 –848.80.8MHz were measured using a substitution method. The EUT was replaced by dipole antenna connected, the S.G. output was recorded and ERP was calculated as follows:		
	 ERP = S.G. output (dBm) + Antenna Gain (dBd) – Cable Loss (dB) 4. EIRP in frequency band 1850.2 –1909.8MHz were measured using a substitution method. The EUT was replaced by or horn antenna connected, the S.G. output was recorded and EIRP was calculated as follows: 		
	EIRP = S.G. output (dBm) + Antenna Gain (dBi) – Cable Loss (dB) 5. The worse case was relating to the conducted output power.		
Toot Instruments:			
Test Instruments:	Refer to section 5.8 for details		
Test mode:	Refer to section 5.3 for details		
Test results:	Passed (All three channels were tested, and just the worst case data were shown in the report.)		

Measurement Data (worst case)

EUT mode	Channel	EUT Pol.	Antenna Pol.	ERP(dBm)	Limit (dBm)	Result
0011050	054	1.1	V	14.09	20.45	Dana
GSM850	251	Н	Н	18.46	38.45	Pass

EUT mode	Channel	EUT Pol.	Antenna Pol.	EIRP(dBm)	Limit (dBm)	Result
DCC1000	940	ш	V	20.25	22.00	Door
PCS1900	810	H	Н	24.56	33.00	Pass



6.10 Field strength of spurious radiation measurement

Test Requirement:	FCC part 22.917(a) and FCC part 24.238(a)
Test Method:	FCC part 2.1053
Limit:	-13dBm
Test setup:	Below 1GHz Antenna Tower Search Antenna RF Test Receiver Ground Plane Above 1GHz
	Antenna Tower Horn Antenna Spectrum Analyzer Turn Table Amplifier
	Substituted method:
	Ground plane d: distance in meters d:3 meter 1-4 meter SPA Substituted Dipole or Horn Antenna Bi-Log Antenna or Horn Antenna
Test Procedure:	 The EUT was placed on an non-conductive turntable using a non-conductive support. The radiated emission at the fundamental frequency was measured at 3 m with a test antenna and EMI spectrum analyzer. During the tests, the antenna height and the EUT azimuth were varied in order to identify the maximum level of emissions from the EUT. This maximization process was repeated with the EUT positioned in each of its three orthogonal orientations. The frequency range up to tenth harmonic was investigated for each of three fundamental frequency (low, middle and high channels). Once spurious emission was identified, the power of the emission was determined using the substitution method.





	4. The spurious emissions attenuation was calculated as the difference between radiated power at the fundamental frequency and the spurious emissions frequency. ERP / EIRP = S.G. output (dBm) + Antenna Gain(dB/dBi) – Cable Loss (dB)
Test Instruments:	Refer to section 5.8 for details
Test mode:	Refer to section 5.3 for details.
	Based on the ERP/EIRP results, we selected GSM850, PCS1900 for Radiated spurious emission test, other modes were not test.
Test results:	Passed





Measurement Data (worst case)

Test mode:	GSI	M850	Test channel:	Lowest	
Frequency (MHz)	Spurious	Emission	Limit (dBm)	Result	
1 requericy (IVII IZ)	Polarization	Level (dBm)	Limit (dbin)	Nesuit	
1648.40	Vertical	-44.39			
2472.60	V	-44.45			
3296.80	V	-49.07	-13.00	Pass	
4121.00	V	-49.99			
4945.20	V	-45.10			
1648.40	Horizontal	-43.98			
2472.60	Н	-44.70]		
3296.80	Н	-50.83	-13.00	Pass	
4121.00	Н	-50.07	1		
4945.20	Н	-46.58	1		
Test mode:	GSI	M850	Test channel:	Middle	
Fraguesia (MIII-)	Spurious	Emission			
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Result	
1673.20	Vertical	-44.74			
2509.80	V	-46.61	1	Pass	
3346.40	V	-50.20	-13.00		
4183.00	V	-49.93			
5019.60	V	-44.48	1		
1673.20	Horizontal	-43.86		Pass	
2509.80	Н	-45.91	1		
3346.40	Н	-51.16	-13.00		
4183.00	Н	-49.28			
5019.60	Н	-45.93			
Test mode:	GSI	M850	Test channel:	Highest	
F (1411)	Spurious	Emission	1: :: (15.)	D 1	
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Result	
1697.60	Vertical	-46.12			
2546.40	V	-49.58			
3395.20	V	-48.04	-13.00	Pass	
4244.00	V	-49.46			
5092.80	V	-46.44	1		
1697.60	Horizontal	-45.71			
2546.40	Н	-48.66			
3395.20	Н	-49.80	-13.00	Pass	
4244.00	Н	-49.97	1	1 433	
5092.80	Н	-45.68	1		

Remark

1. The emission levels of below 1 GHz are very lower than the limit and not show in test report.





Test mode:	PCS1900		Test channel:	Lowest	
Frequency (MHz)	Spurious	Emission	Limit (dBm)	Result	
Frequency (Wiriz)	Polarization	Level (dBm)	Lillill (dBill)		
3700.40	Vertical	-46.44	-13.00	Door	
5550.60	V	-36.73	-13.00	Pass	
3700.40	Horizontal	-46.31	-13.00	Pass	
5550.60	Н	-37.40	-13.00	Pa55	
Test mode:	PCS	1900	Test channel:	Middle	
Frequency (MHz)	Spurious	Emission	Limit (dBm)	Result	
Frequency (IVII 12)	Polarization	Level (dBm)	Limit (dbin)	Resuit	
3760.00	Vertical	-43.65	-13.00	Door	
5640.00	V	-39.80	-13.00	Pass	
3760.00	Horizontal	-47.43	-13.00	Pass	
5640.00	Н	-37.17	-13.00	Pa55	
Test mode:	PCS	1900	Test channel:	Highest	
Frequency (MHz)	Spurious	Emission	Limit (dBm)	Result	
Frequency (MHZ)	Polarization	Level (dBm)	Limit (dbm)	Result	
3819.60	Vertical	-46.41	-13.00	Pass	
5729.40	V	-37.27	-13.00	Fa55	
3819.60	Horizontal	-46.86	12.00	Door	
5729.40	Н	-46.48	-13.00	Pass	

Remark:

^{1.} The emission levels of below 1 GHz are very lower than the limit and not show in test report.



6.11 Frequency stability V.S. Temperature measurement

Test Requirement:	FCC Part 2.1055(a)(1)(b)
Test Method:	FCC Part 2.1055(a)(1)(b)
Limit:	2.5 ppm
Test setup:	Spectrum analyzer EUT Att. Variable Power Supply
Test procedure:	 Note: Measurement setup for testing on Antenna connector The equipment under test was connected to an external DC power supply and input rated voltage. RF output was connected to a frequency counter or spectrum analyzer via feed through attenuators. The EUT was placed inside the temperature chamber. Set the spectrum analyzer RBW low enough to obtain the desired frequency resolution and measure EUT 25°C operating frequency as reference frequency. Turn EUT off and set the chamber temperature to -30°C. After the temperature stabilized for approximately 30 minutes recorded the frequency. Repeat step measure with 10°C increased per stage until the highest temperature of +50°C reached
Test Instruments:	Refer to section 5.8 for details
Test mode:	Refer to section 5.3 for details
Test results:	Passed
Remark:	All three channels of all modulations have been tested, but only the worst channel and the worst modulation show in this test item.





Measurement Data:

	leasurement Data:					
Reference Frequency: GSM850 Middle channel=190 channel=836.6MHz						
Power supplied	Temperature (°C)	Fr	equency error	Limit (ppm)	Result	
(Vdc)	Tomporatoro (c)	Hz	ppm	Ziriit (ppiii)	rtoodit	
	-30	182	0.217547			
	-20	151	0.180492			
	-10	148	0.176907			
	0	134	0.160172			
3.70	10	91	0.108774	2.5	Pass	
	20	93	0.111164			
	30	108	0.129094			
	40	112	0.133875			
	50	136	0.162563			
Refe	erence Frequency: PO	CS1900 Mid	dle channel=661 chann	el=1880MHz		
Power supplied	Tomporature (°C)	Frequency error		Limit (nnm)	Result	
(Vdc)	Temperature (°C)	Hz	ppm	Limit (ppm)	Result	
	-30	178	0.094681			
	-20	91	0.048404			
	-10	152	0.080851			
	0	157	0.083511			
3.70	10	136	0.072340	2.5	Pass	
	20	146	0.077660			
	30	99	0.052660			
	40	105	0.055851			
	50	100	0.053191			



6.12 Frequency stability V.S. Voltage measurement

Test Requirement:	FCC Part 2.1055(d)(1)(2)		
Test Method:	FCC Part 2.1055(d)(1)(2)		
Limit:	2.5ppm		
Test setup:	Temperature Chamber		
	Spectrum analyzer EUT Variable Power Supply Note: Measurement setup for testing on Antenna connector		
Test procedure:	 Set chamber temperature to 25°C. Use a variable DC power source to power the EUT and set the voltage to rated voltage. Set the spectrum analyzer RBW low enough to obtain the desired frequency resolution and recorded the frequency. Reduce the input voltage to specify extreme voltage variation (+/-15%) and endpoint, record the maximum frequency change. 		
Test Instruments:	Refer to section 5.8 for details		
Test mode:	Refer to section 5.3 for details, and all channels have been tested, only shows the worst channel data in this report.		
Test results:	Passed		

Measurement Data (the worst channel):

Reference Frequency: GSM850 Middle channel=190 channel=836.6MHz						
Temperature (°C)	Power supplied	• •		Limit (ppm)	Result	
. ,	(Vdc)	Hz	ppm	Еппи (ррпп)	resuit	
	4.25	109	0.130289			
25	3.70	62	0.074109	2.5	Pass	
	3.40	97	0.115945			
Refe	erence Frequency: Po	CS1900 Middle ch	annel=661 chann	el=1880MHz		
	Power supplied	Freguer	ncy error			
Temperature (℃)	(Vdc)	Hz	ppm	Limit (ppm)	Result	
	4.25	98	0.052128			
25	3.70	55	0.029255	2.5	Pass	
	3.40	67	0.035638			